

# OptiMOS™ 2 + OptiMOS™-P 2 Small Signal Transistor

## Features

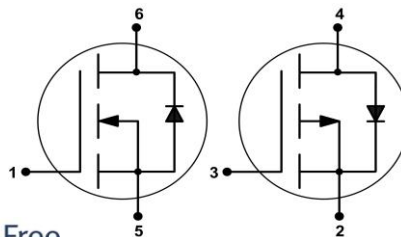
- Complementary P + N channel
- Enhancement mode
- Logic level (4.5V rated)
- Avalanche rated
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant
- Halogen free according to IEC61249-2-21

## Product Summary

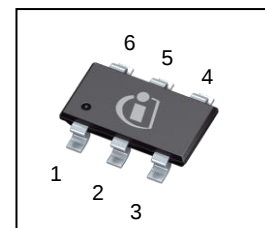
|                  |                           | P    | N   |    |
|------------------|---------------------------|------|-----|----|
| $V_{DS}$         |                           | -30  | 30  | V  |
| $R_{DS(on),max}$ | $V_{GS}=\pm 10\text{ V}$  | 150  | 160 | mΩ |
|                  | $V_{GS}=\pm 4.5\text{ V}$ | 270  | 280 |    |
| $I_D$            |                           | -1.5 | 1.4 | A  |



Halogen-Free



PG-TSOP6



| Type    | Package   | Tape and Reel Information | Marking | Lead Free | Packing |
|---------|-----------|---------------------------|---------|-----------|---------|
| BSL316C | PG-TSOP-6 | H6327: 3000 pcs / reel    | sPJ     | Yes       | Non dry |

Maximum ratings, at  $T_j=25\text{ °C}$ , unless otherwise specified <sup>1)</sup>

| Parameter                           | Symbol         | Conditions                                                                  | Value       |     | Unit |
|-------------------------------------|----------------|-----------------------------------------------------------------------------|-------------|-----|------|
|                                     |                |                                                                             | P           | N   |      |
| Continuous drain current            | $I_D$          | $T_A=25\text{ °C}$                                                          | -1.5        | 1.4 | A    |
|                                     |                | $T_A=70\text{ °C}$                                                          | -1.2        | 1.1 |      |
| Pulsed drain current                | $I_{D,pulse}$  | $T_A=25\text{ °C}$                                                          | -6.0        | 5.6 |      |
| Avalanche energy, single pulse      | $E_{AS}$       | P: $I_D=-1.5\text{ A}$ ,<br>N: $I_D=1.4\text{ A}$ ,<br>$R_{GS}=25\text{ Ω}$ | 11          | 3.7 | mJ   |
| Gate source voltage                 | $V_{GS}$       |                                                                             | $\pm 20$    |     | V    |
| Power dissipation <sup>1)</sup>     | $P_{tot}$      | $T_A=25\text{ °C}$                                                          | 0.5         |     | W    |
| Operating and storage temperature   | $T_j, T_{stg}$ |                                                                             | -55 ... 150 |     | °C   |
| ESD class                           |                | JESD22-A114-HBM                                                             | 0 (<250V)   |     |      |
| Soldering temperature               | $T_{solder}$   |                                                                             | 260         |     | °C   |
| IEC climatic category; DIN IEC 68-1 |                |                                                                             | 55/150/56   |     |      |

<sup>1)</sup> Remark: only one of both transistors active

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Thermal characteristics

|                                                      |   |            |                                 |   |   |     |     |
|------------------------------------------------------|---|------------|---------------------------------|---|---|-----|-----|
| Thermal resistance, junction - ambient <sup>1)</sup> | P | $R_{thJA}$ | minimal footprint <sup>2)</sup> | - | - | 250 | K/W |
|                                                      | N |            |                                 |   |   |     |     |

### Electrical characteristics, at $T_j=25\text{ }^{\circ}\text{C}$ , unless otherwise specified

#### Static characteristics

|                                  |   |               |                                                                           |     |      |           |                  |
|----------------------------------|---|---------------|---------------------------------------------------------------------------|-----|------|-----------|------------------|
| Drain-source breakdown voltage   | P | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}, I_D=-250\text{ }\mu\text{A}$                          | -   | -    | -30       | V                |
|                                  | N |               | $V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}$                           | 30  | -    | -         |                  |
| Gate threshold voltage           | P | $V_{GS(th)}$  | $V_{DS}=V_{GS}, I_D=-11\text{ }\mu\text{A}$                               | -2  | -1.5 | -1        |                  |
|                                  | N |               | $V_{DS}=V_{GS}, I_D=3.7\text{ }\mu\text{A}$                               | 1.2 | 1.6  | 2         |                  |
| Zero gate voltage drain current  | P | $I_{DSS}$     | $V_{DS}=-30\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^{\circ}\text{C}$  | -   | -    | -1        | $\mu\text{A}$    |
|                                  | N |               | $V_{DS}=30\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^{\circ}\text{C}$   | -   | -    | 1         |                  |
|                                  | P |               | $V_{DS}=-30\text{ V}, V_{GS}=0\text{ V}, T_j=150\text{ }^{\circ}\text{C}$ | -   | -    | -100      |                  |
|                                  | N |               | $V_{DS}=30\text{ V}, V_{GS}=0\text{ V}, T_j=150\text{ }^{\circ}\text{C}$  | -   | -    | 100       |                  |
| Gate-source leakage current      | P | $I_{GSS}$     | $V_{GS}=\pm 20\text{ V}, V_{DS}=0\text{ V}$                               | -   | -    | $\pm 100$ | nA               |
|                                  | N |               |                                                                           |     |      |           |                  |
| Drain-source on-state resistance | P | $R_{DS(on)}$  | $V_{GS}=-4.5\text{ V}, I_D=-1.1\text{ A}$                                 | -   | 177  | 270       | $\text{m}\Omega$ |
|                                  | N |               | $V_{GS}=4.5\text{ V}, I_D=-1.1\text{ A}$                                  | -   | 191  | 280       |                  |
|                                  | P |               | $V_{GS}=-10\text{ V}, I_D=-1.5\text{ A}$                                  | -   | 113  | 150       |                  |
|                                  | N |               | $V_{GS}=10\text{ V}, I_D=1.4\text{ A}$                                    | -   | 119  | 160       |                  |
| Transconductance                 | P | $g_{fs}$      | $ V_{DS}  > 2 I_D R_{DS(on)max}, I_D=-1.18\text{ A}$                      | -   | 2.7  | -         | S                |
|                                  | N |               | $ V_{DS}  > 2 I_D R_{DS(on)max}, I_D=1.1\text{ A}$                        | -   | 2.3  | -         |                  |

<sup>2)</sup> Performed on 40mm<sup>2</sup> FR4 PCB. The traces are 1mm wide, 70μm thick and 20mm long; they are present on both sides of the PCB

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Dynamic characteristics

|                              |   |              |                                                                                                                                                                                                               |   |      |     |    |
|------------------------------|---|--------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---|------|-----|----|
| Input capacitance            | P | $C_{iss}$    | $V_{GS}=0\text{ V}$ ,<br>P: $V_{DS}=-15\text{ V}$ ,<br>N: $V_{DS}=15\text{ V}$ ,<br>$f=1\text{ MHz}$                                                                                                          | - | 212  | 282 | pF |
|                              | N |              |                                                                                                                                                                                                               | - | 71   | 94  |    |
| Output capacitance           | P | $C_{oss}$    |                                                                                                                                                                                                               | - | 69   | 91  |    |
|                              | N |              |                                                                                                                                                                                                               | - | 26   | 35  |    |
| Reverse transfer capacitance | P | $C_{rss}$    |                                                                                                                                                                                                               | - | 56   | 84  |    |
|                              | N |              |                                                                                                                                                                                                               | - | 5    | 7   |    |
| Turn-on delay time           | P | $t_{d(on)}$  | P: $V_{DD}=-15\text{ V}$ ,<br>$V_{GS}=-10\text{ V}$ , $R_G=6\text{ }\Omega$ ,<br>$I_D=-1.5\text{ A}$<br><br>N: $V_{DD}=15\text{ V}$ ,<br>$V_{GS}=10\text{ V}$ , $R_G=6\text{ }\Omega$ ,<br>$I_D=1.4\text{ A}$ | - | 5.0  | -   | ns |
|                              | N |              |                                                                                                                                                                                                               | - | 3.4  | -   |    |
| Rise time                    | P | $t_r$        |                                                                                                                                                                                                               | - | 6.5  | -   |    |
|                              | N |              |                                                                                                                                                                                                               | - | 2.3  | -   |    |
| Turn-off delay time          | P | $t_{d(off)}$ |                                                                                                                                                                                                               | - | 14.3 | -   |    |
|                              | N |              |                                                                                                                                                                                                               | - | 5.8  | -   |    |
| Fall time                    | P | $t_f$        |                                                                                                                                                                                                               | - | 7.5  | -   |    |
|                              | N |              |                                                                                                                                                                                                               | - | 1.0  | -   |    |

### Gate Charge Characteristics

|                       |   |               |                                                                                      |   |      |   |    |
|-----------------------|---|---------------|--------------------------------------------------------------------------------------|---|------|---|----|
| Gate to source charge | P | $Q_{gs}$      | $V_{DD}=-15\text{ V}$ ,<br>$I_D=-1.5\text{ A}$ ,<br>$V_{GS}=0\text{ to }-5\text{ V}$ | - | -0.6 | - | nC |
| Gate to drain charge  |   | $Q_{gd}$      |                                                                                      | - | -1.2 | - |    |
| Switching charge      |   | $Q_g$         |                                                                                      | - | -2.4 | - |    |
| Gate plateau voltage  |   | $V_{plateau}$ |                                                                                      | - | -2.9 | - |    |
| Gate to source charge | N | $Q_{gs}$      | $V_{DD}=15\text{ V}$ ,<br>$I_D=1.4\text{ A}$ ,<br>$V_{GS}=0\text{ to }5\text{ V}$    | - | 0.3  | - |    |
| Gate to drain charge  |   | $Q_{gd}$      |                                                                                      | - | 0.2  | - |    |
| Switching charge      |   | $Q_g$         |                                                                                      |   | 0.6  | - |    |
| Gate plateau voltage  |   | $V_{plateau}$ |                                                                                      | - | 3.4  | - |    |

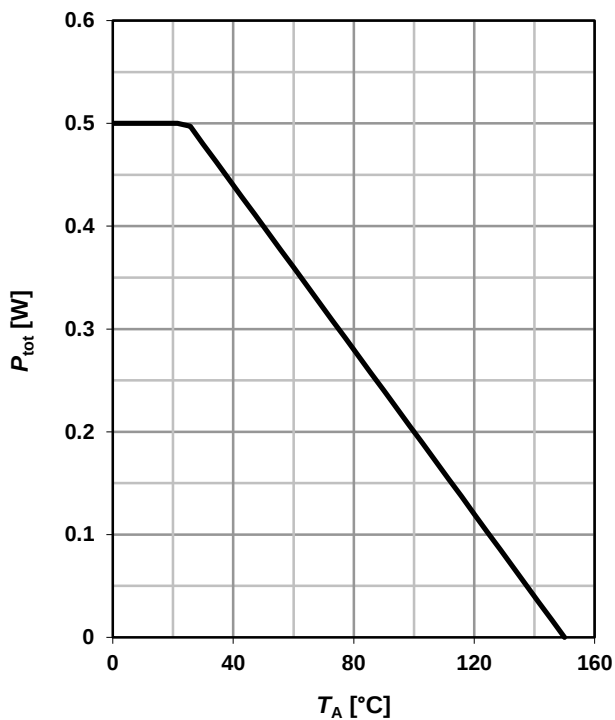
| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Reverse Diode

|                                  |   |               |                                                                  |   |      |      |    |
|----------------------------------|---|---------------|------------------------------------------------------------------|---|------|------|----|
| Diode continuous forward current | P | $I_S$         | $T_C=25\text{ °C}$                                               | - | -    | -0.5 | A  |
|                                  | N |               |                                                                  | - | -    | 0.5  |    |
| Diode pulse current              | P | $I_{S,pulse}$ |                                                                  | - | -    | -6.0 |    |
|                                  | N |               |                                                                  | - | -    | 5.6  |    |
| Diode forward voltage            | P | $V_{SD}$      | $V_{GS}=0\text{ V}, I_F=-1.5\text{ A}, T_j=25\text{ °C}$         | - | -0.8 | -1.1 | V  |
|                                  | N |               | $V_{GS}=0\text{ V}, I_F=1.4\text{ A}, T_j=25\text{ °C}$          | - | 0.86 | 1.1  |    |
| Reverse recovery time            | P | $t_{rr}$      | $V_R=\pm 15\text{ V}, I_F=I_S, di_F/dt=100\text{ A}/\mu\text{s}$ | - | 8.2  | -    | ns |
|                                  | N |               |                                                                  | - | 9.1  | -    |    |
| Reverse recovery charge          | P | $Q_{rr}$      |                                                                  | - | 2.1  | -    | nC |
|                                  | N |               |                                                                  | - | 2.6  | -    |    |

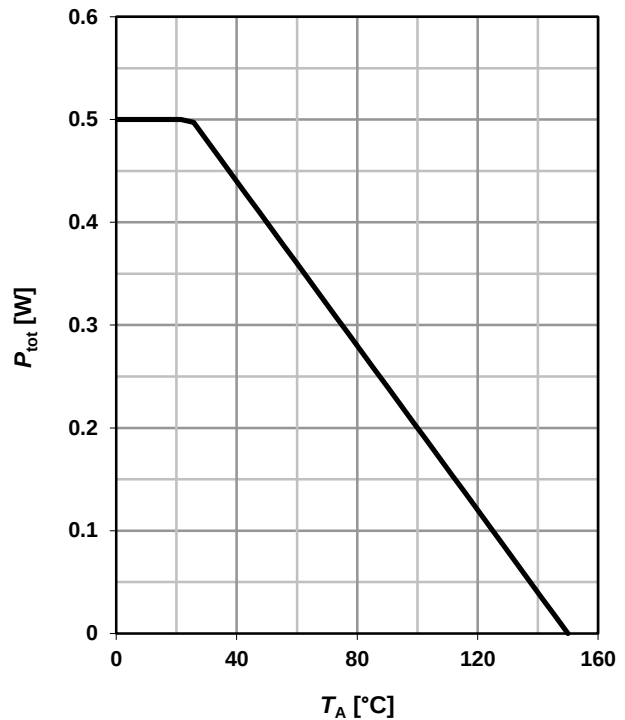
### 1 Power dissipation (P)

$$P_{\text{tot}} = f(T_A)$$



### 2 Power dissipation (N)

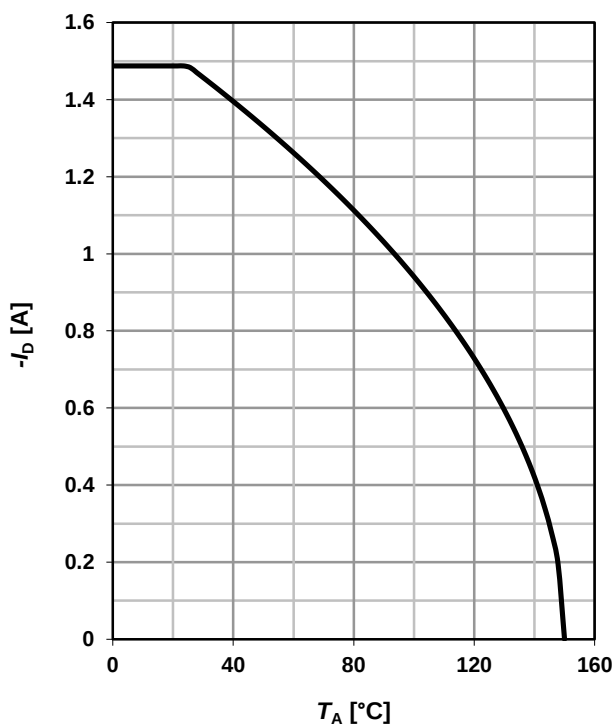
$$P_{\text{tot}} = f(T_A)$$



### 3 Drain current (P)

$$I_D = f(T_A)$$

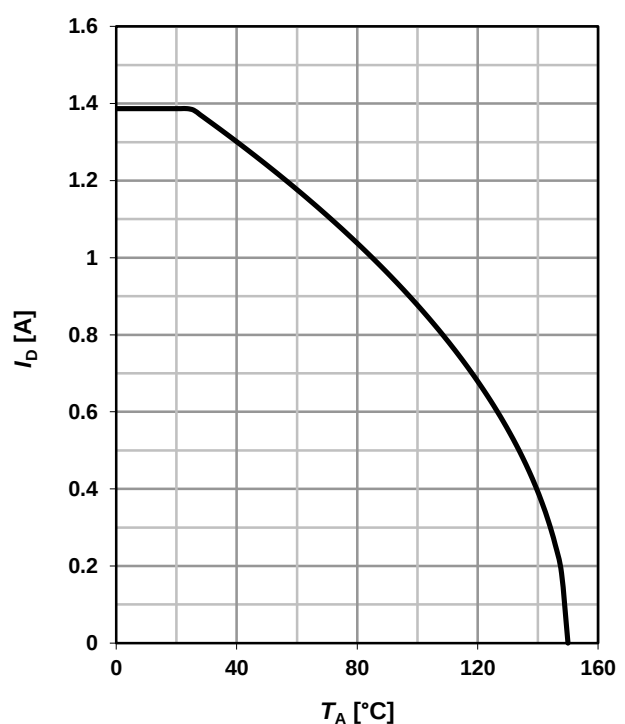
parameter:  $V_{GS} \leq -10$  V



### 4 Drain current (N)

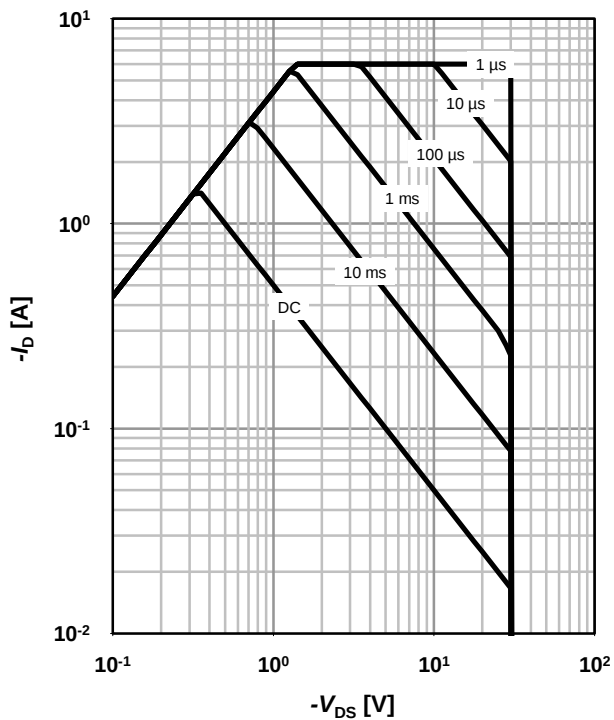
$$I_D = f(T_A)$$

parameter:  $V_{GS} \geq 10$  V



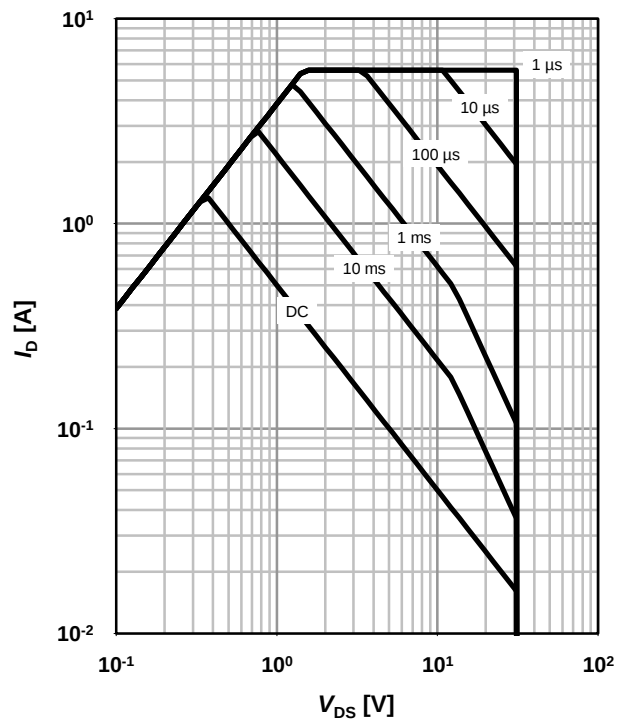
## 5 Safe operating area (P)

 $I_D = f(V_{DS}); T_A = 25^\circ\text{C}; D = 0$ 

parameter:  $t_p$ 


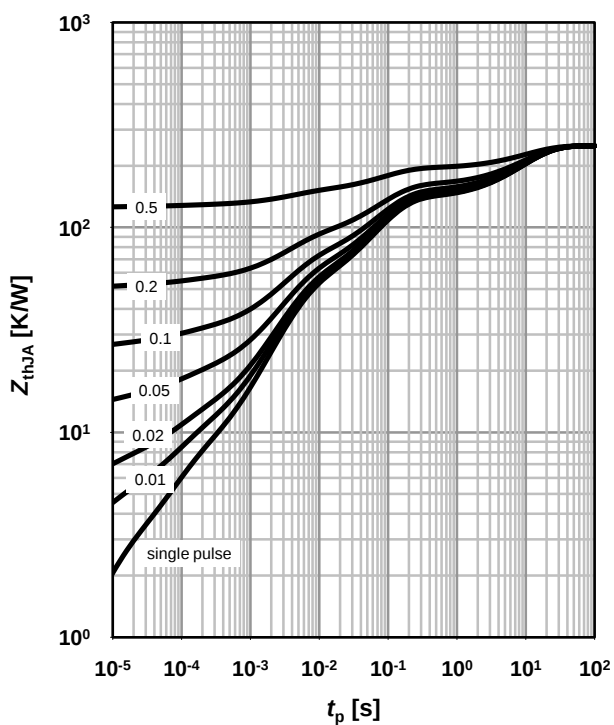
## 6 Safe operating area (N)

 $I_D = f(V_{DS}); T_A = 25^\circ\text{C}; D = 0$ 

parameter:  $t_p$ 


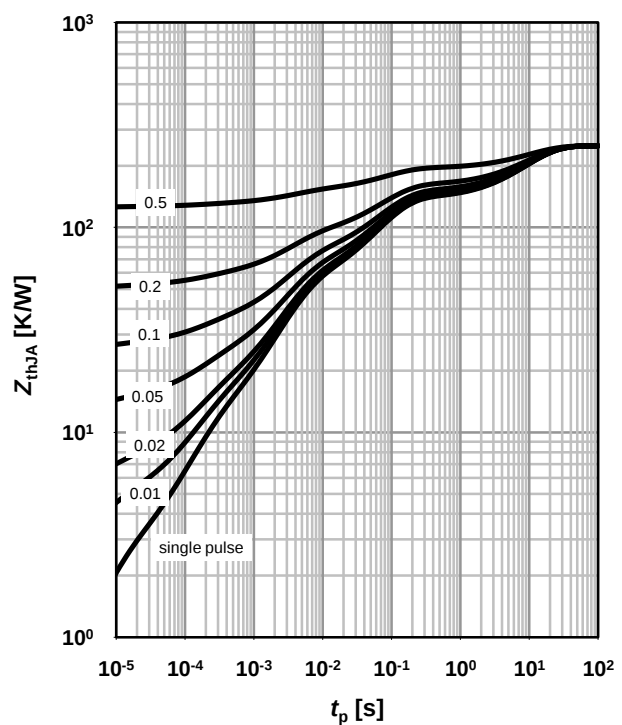
## 7 Max. transient thermal impedance (P)

 $Z_{thJA} = f(t_p)$ 

parameter:  $D = t_p/T$ 


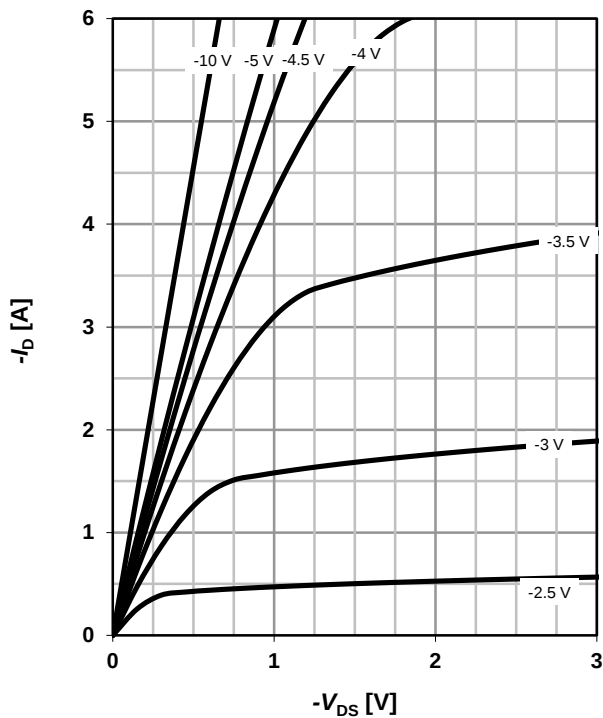
## 8 Max. transient thermal impedance (N)

 $Z_{thJA} = f(t_p)$ 

parameter:  $D = t_p/T$ 


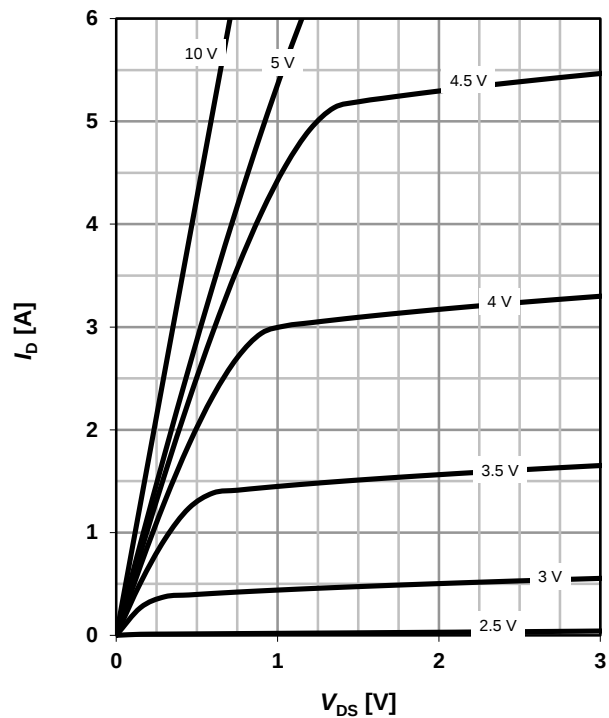
### 9 Typ. output characteristics (P)

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}$ 

parameter:  $V_{GS}$ 


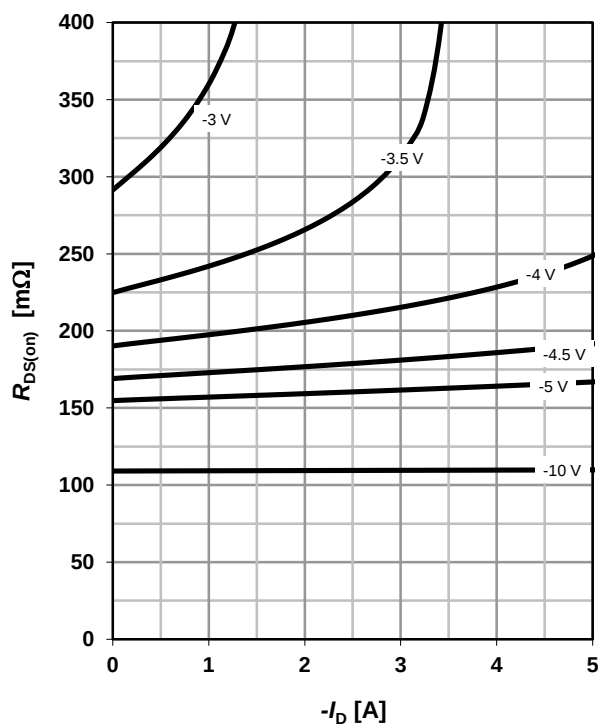
### 10 Typ. output characteristics (N)

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}$ 

parameter:  $V_{GS}$ 


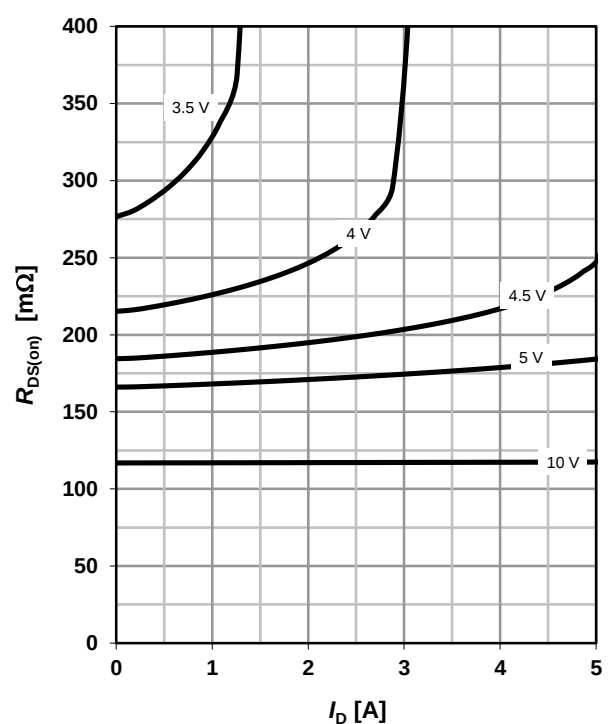
### 11 Typ. drain-source on resistance (P)

 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$ 

parameter:  $V_{GS}$ 


### 12 Typ. drain-source on resistance (N)

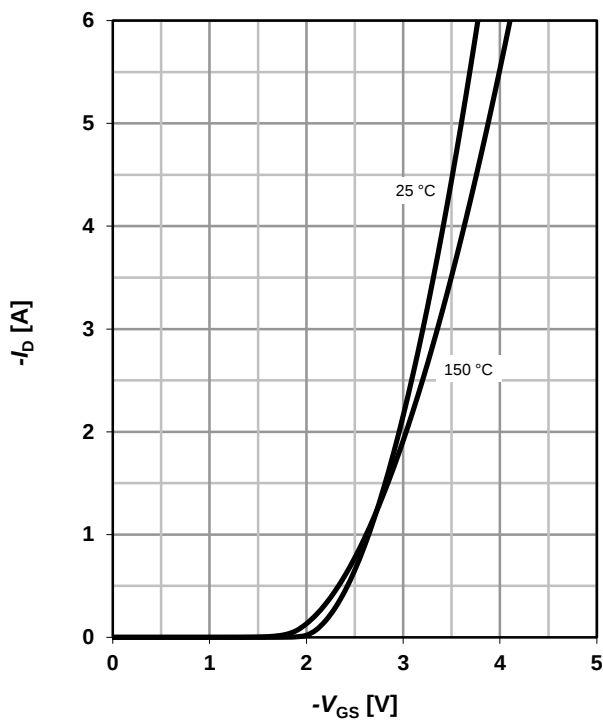
 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$ 

parameter:  $V_{GS}$ 


### 13 Typ. transfer characteristics (P)

$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

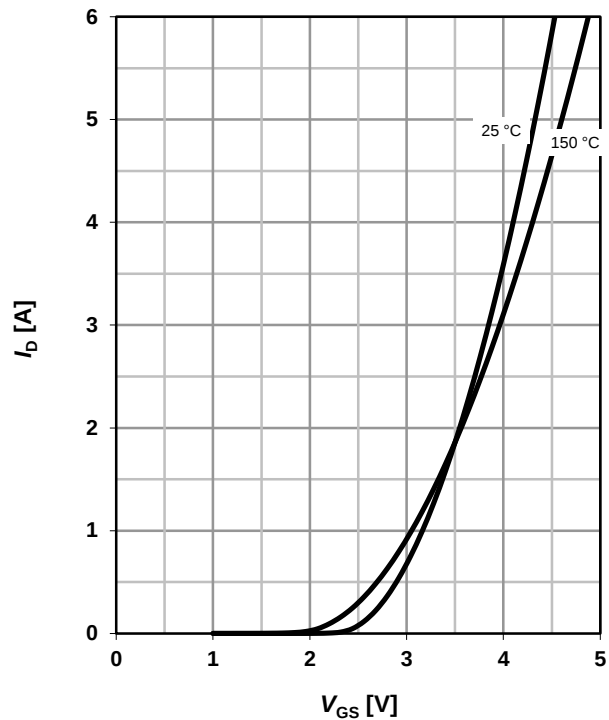
parameter:  $T_j$



### 14 Typ. transfer characteristics (N)

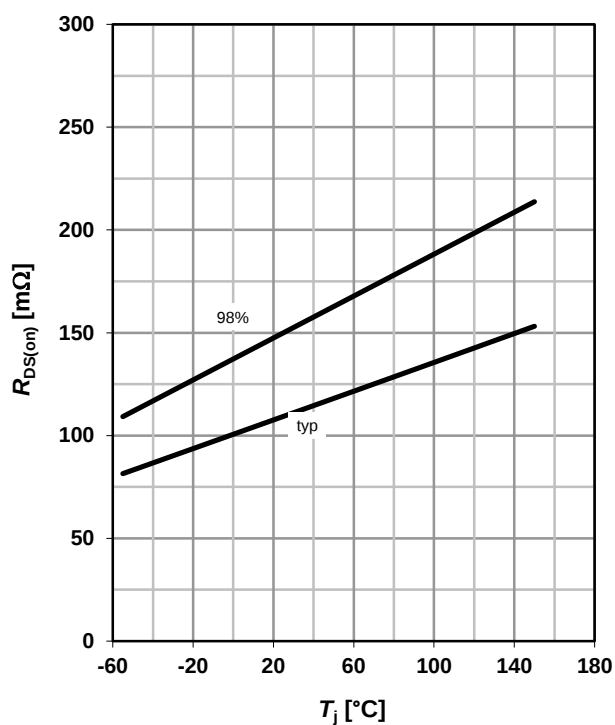
$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

parameter:  $T_j$



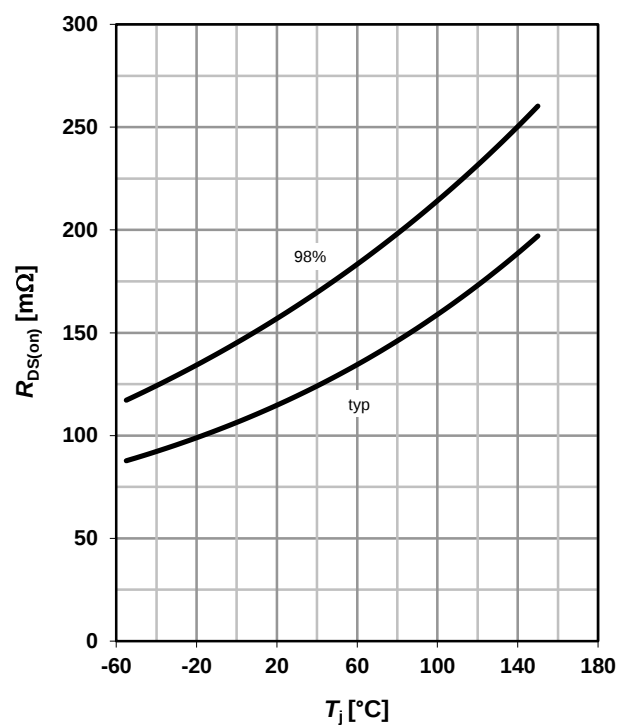
### 15 Drain-source on-state resistance (P)

$$R_{DS(on)} = f(T_j); I_D = -1.5\text{ A}; V_{GS} = -10\text{ V}$$



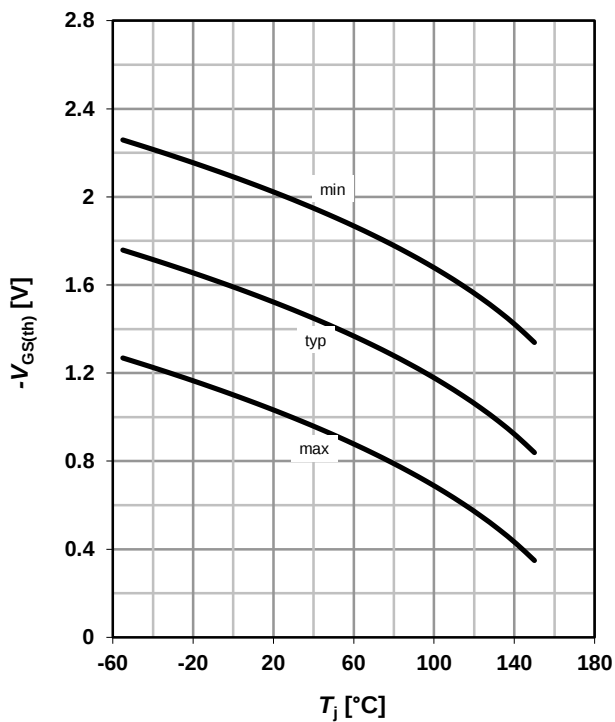
### 16 Drain-source on-state resistance (N)

$$R_{DS(on)} = f(T_j); I_D = 1.4\text{ A}; V_{GS} = 10\text{ V}$$



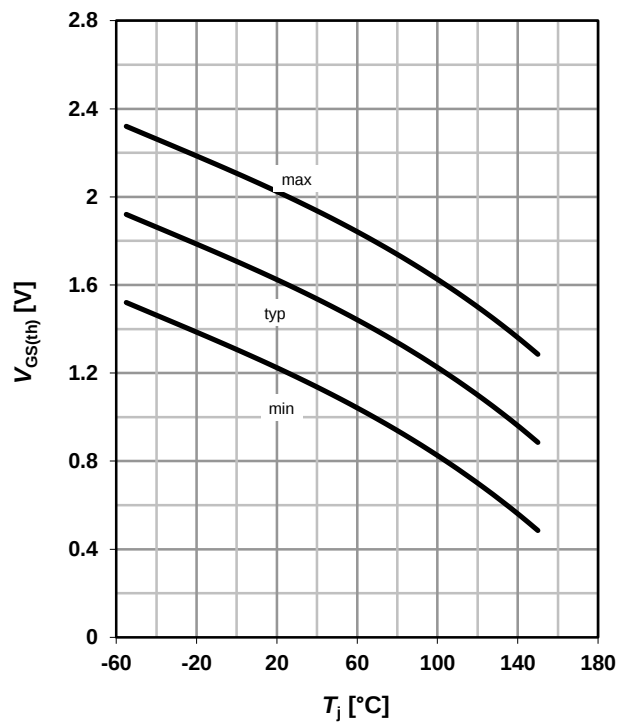
### 17 Typ. gate threshold voltage (P)

$V_{GS(th)} = f(T_j)$ ;  $V_{GS} = V_{DS}$ ;  $I_D = -11 \mu A$



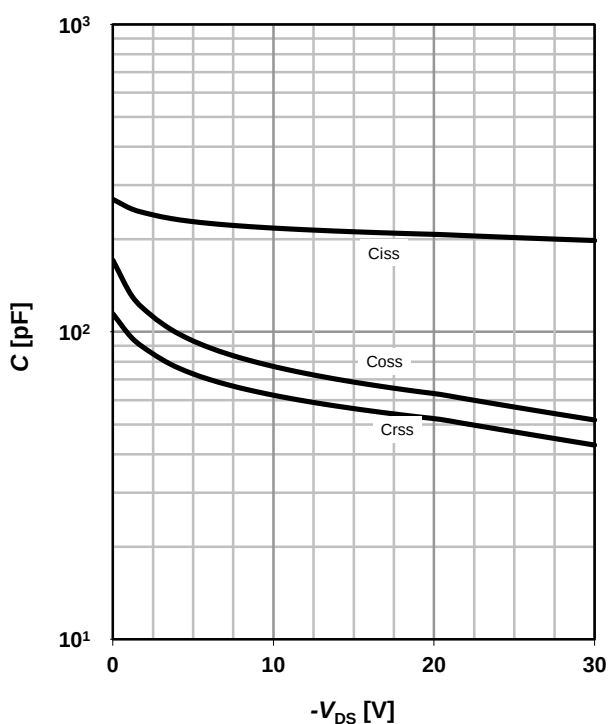
### 18 Typ. gate threshold voltage (N)

$V_{GS(th)} = f(T_j)$ ;  $V_{GS} = V_{DS}$ ;  $I_D = 3.7 \mu A$



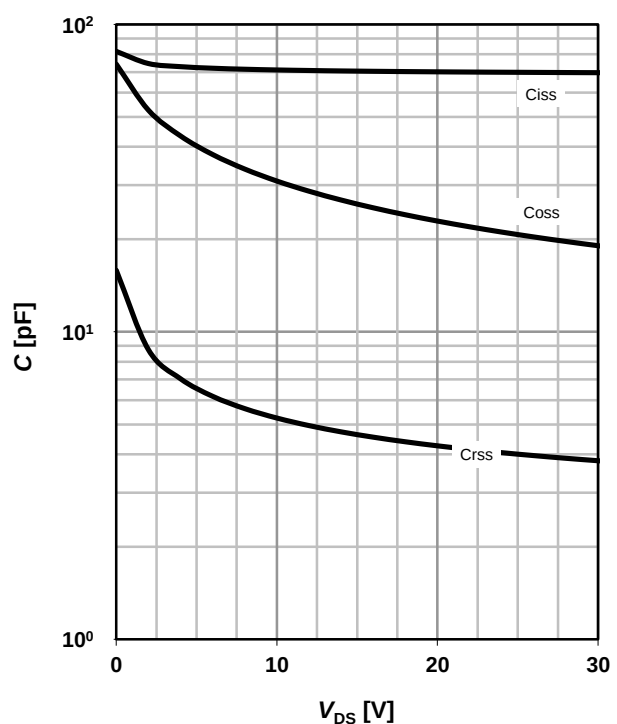
### 19 Typ. capacitances (P)

$C = f(V_{DS})$ ;  $V_{GS} = 0 V$ ;  $f = 1 MHz$



### 20 Typ. capacitances (N)

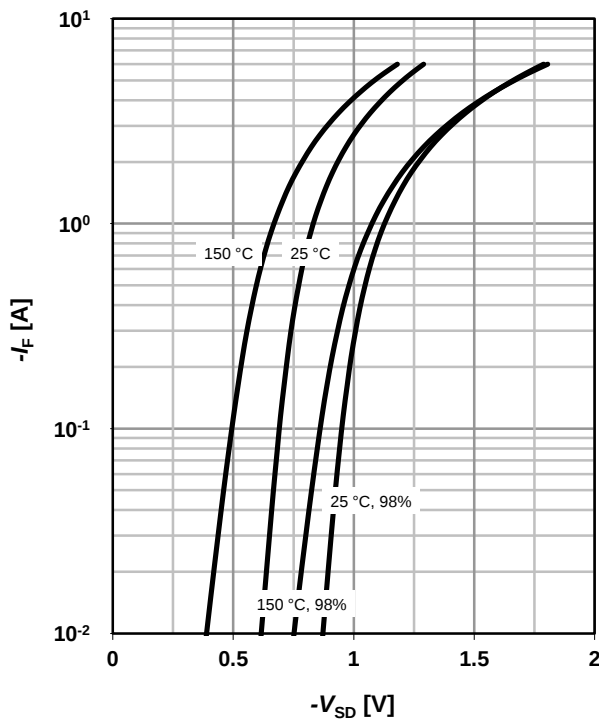
$C = f(V_{DS})$ ;  $V_{GS} = 0 V$ ;  $f = 1 MHz$



## 21 Forward characteristics of reverse diode (P)

$$I_F = f(V_{SD})$$

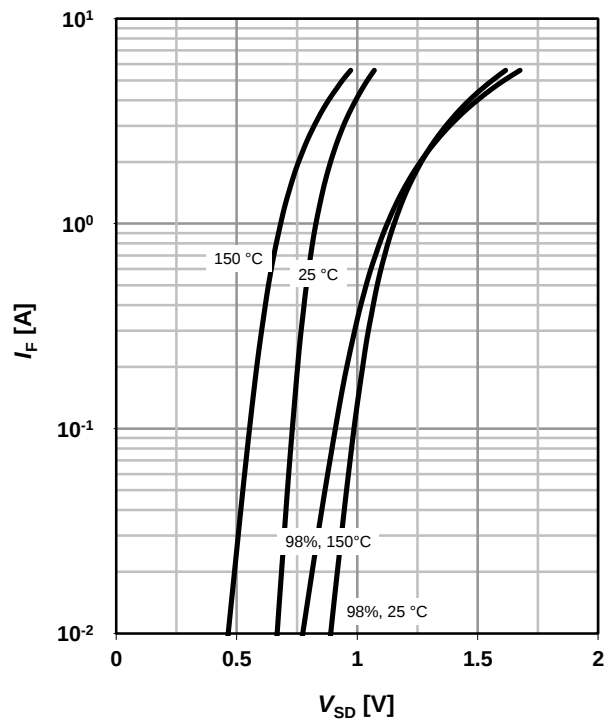
parameter:  $T_j$



## 22 Forward characteristics of reverse diode (N)

$$I_F = f(V_{SD})$$

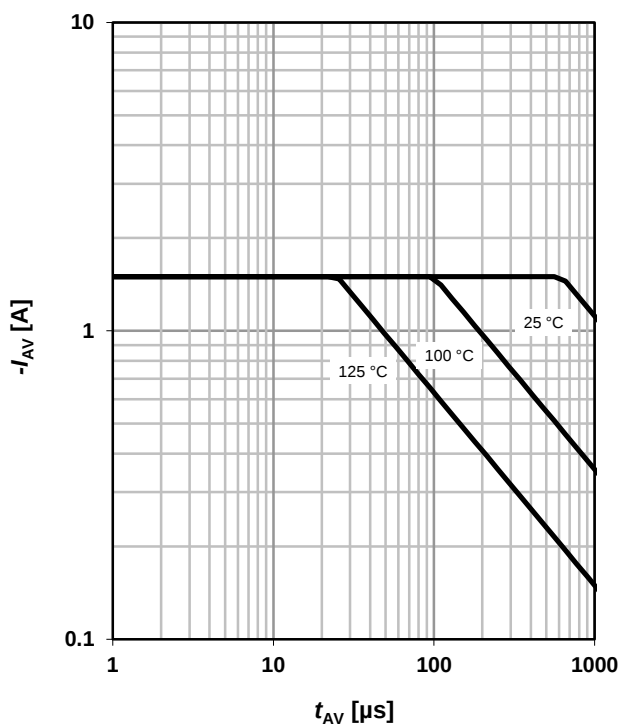
parameter:  $T_j$



## 23 Avalanche characteristics (P)

$$I_{AS} = f(t_{AV}); R_{GS} = 25 \Omega$$

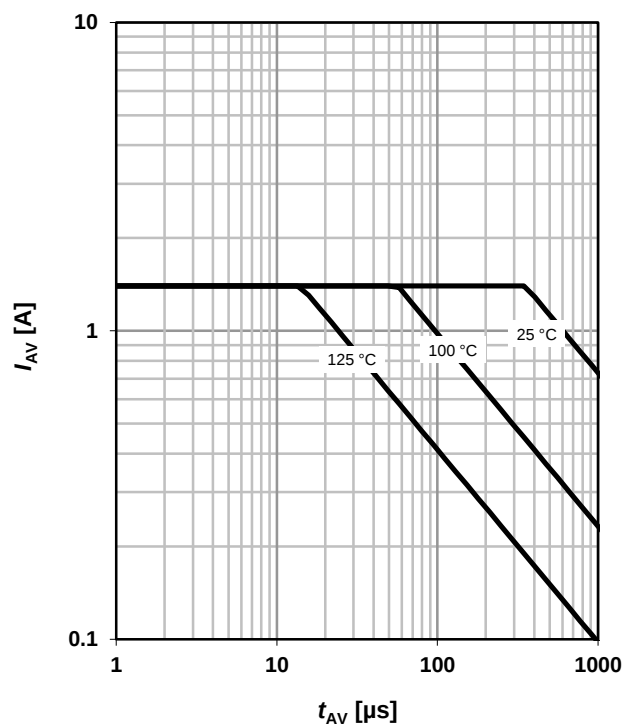
parameter:  $T_{j(start)}$



## 24 Avalanche characteristics (N)

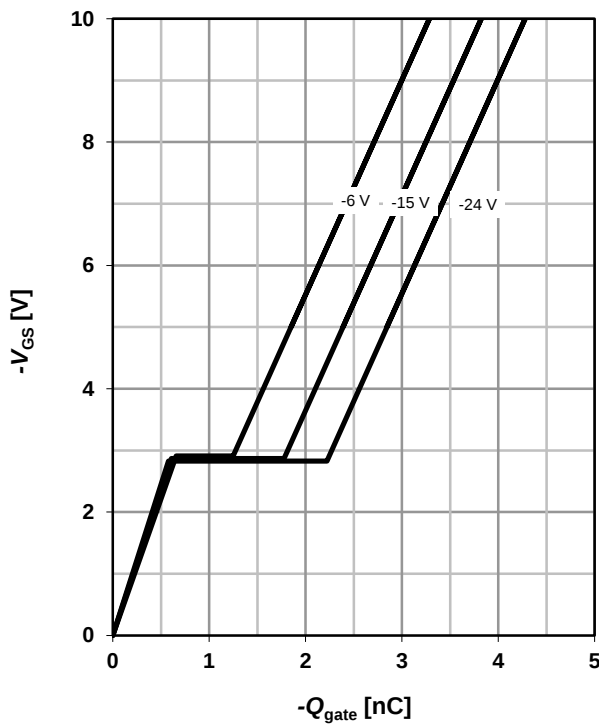
$$I_{AS} = f(t_{AV}); R_{GS} = 25 \Omega$$

parameter:  $T_{j(start)}$



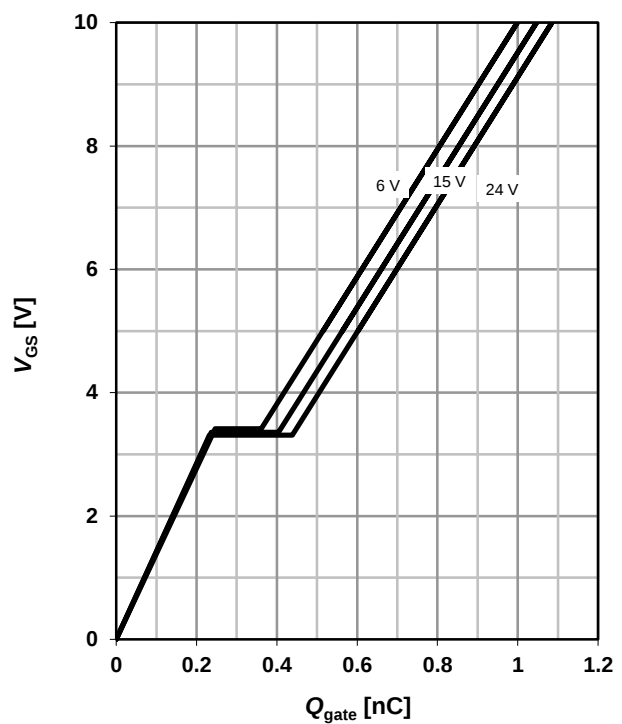
## 25 Typ. gate charge (P)

 $V_{GS}=f(Q_{gate}); I_D=-1.5 \text{ A pulsed}$ 

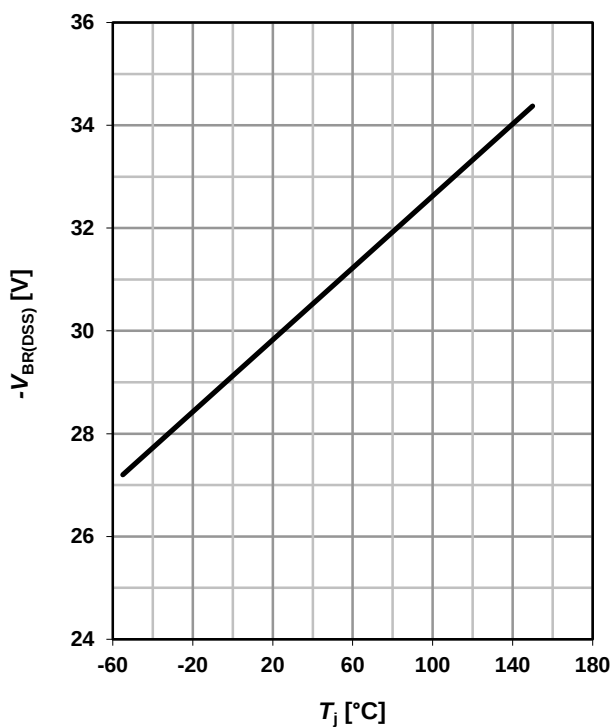
parameter:  $V_{DD}$ 


## 26 Typ. gate charge (N)

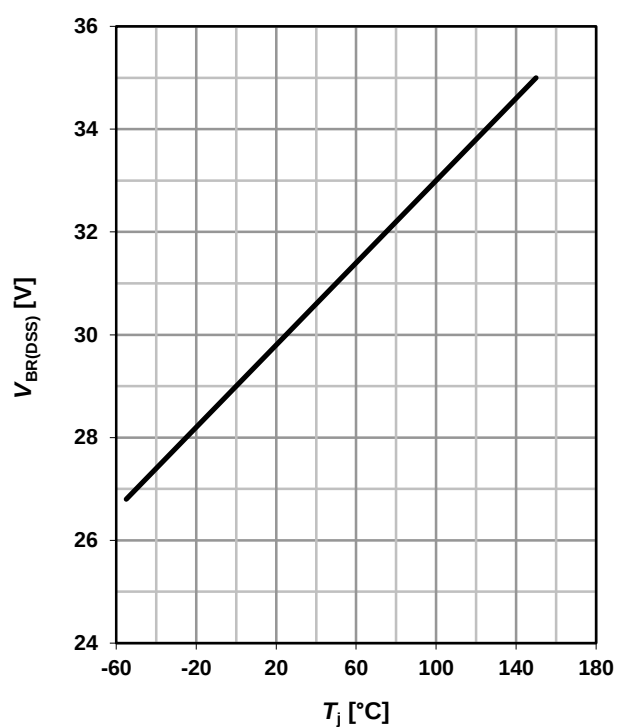
 $V_{GS}=f(Q_{gate}); I_D=1.4 \text{ A pulsed}$ 

parameter:  $V_{DD}$ 


## 27 Drain-source breakdown voltage (P)

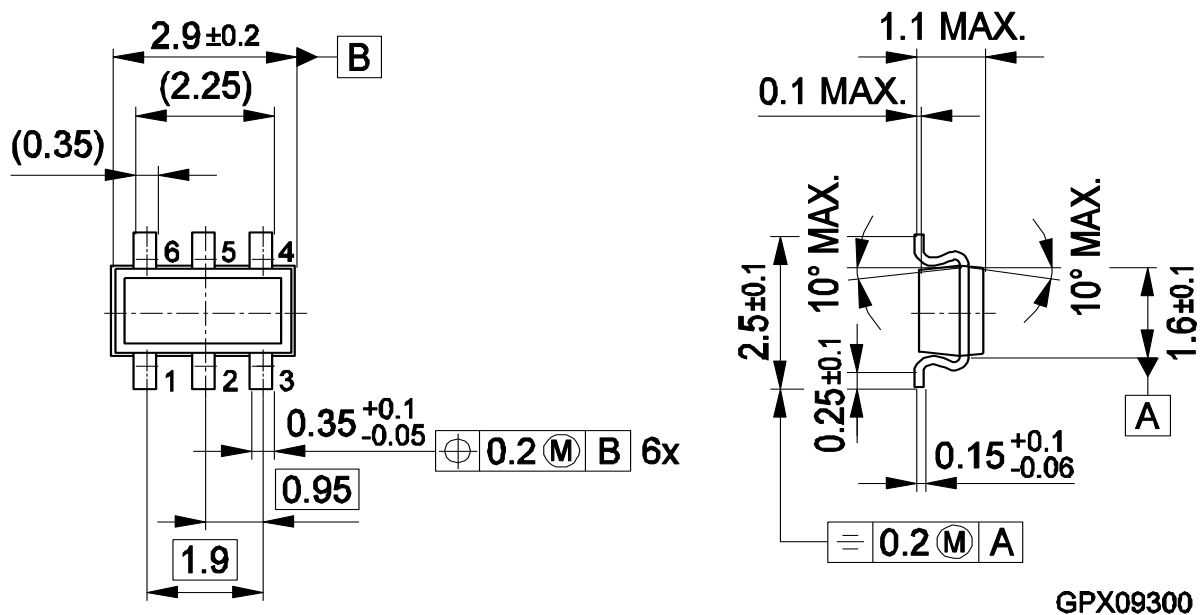
 $V_{BR(DSS)}=f(T_j); I_D=-250 \mu\text{A}$ 


## 28 Drain-source breakdown voltage (N)

 $V_{BR(DSS)}=f(T_j); I_D=250 \mu\text{A}$ 


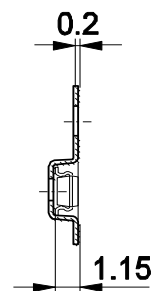
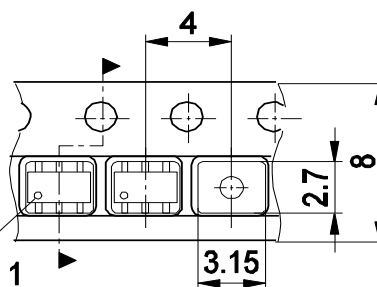
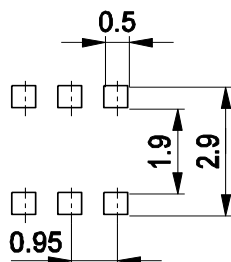
## Package Outline:

## TSOP6



## Footprint:

## Packaging:



Remark: Wave soldering possible dep. on customers process conditions

HLG09283

CPWG5899

Dimensions in mm

Note: For symmetric types there is no defined Pin 1 orientation in the reel.

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For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office ([www.infineon.com](http://www.infineon.com)).

**Warnings**

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